FM-IF IC for the DYNAS ¹⁾ System

Description

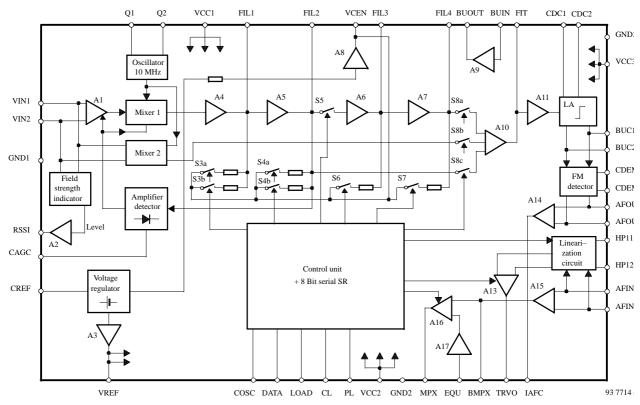
The U42922B is a bipolar integrated FM-IF circuit, which is controlled by software. It performs all the function of the DYNAS system. The device is designed for car radio and home receiver applications.

DYNAS is a complete new system of FM-IF processing. It uses bandpass filters with a bandwidth down to about 20 kHz compared to 160 kHz for a conventional bandpass filter, and tracks the resonant frequency to the actual frequency. Implementation of the DYNAS system drastically enhances both of the basic, classic characteristics of radio reception: selectivity and reception sensitivity.

DYNAS ensures enhancement up to levels which until now were not considered physically feasible. A complete system description can be found in "DYNAS system & it's application in car radios" (Jan. 1992).

Features

- In comparison to conventional FM-IF systems:
 More than 26 dB better selectivity in case of directly (100 kHz) adjacent transmitters
 - Higher sensitivity of typical 6 dB due to the reduction of the effective noise bandwidth
- Higher flexibility by software
- Easy adaption of RDS (Radio data system) and Noise Blanker



Block Diagram

¹⁾ DYNAS stands for dynamic selectivity.

Figure 1.

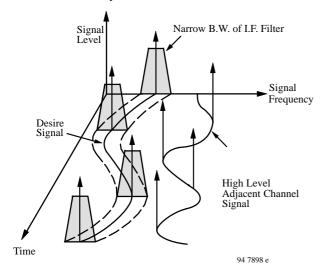
Preliminary Information

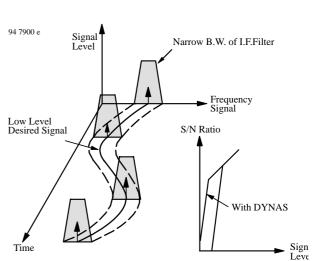
Pin Description

| Pin | Symbol | Function |
|-----|---------|---|
| 1 | CAGC | Time constant for the AGC mixer |
| 2 | CREF | Noise filter for internal reference |
| 3 | VREF | Reference voltage 5 V |
| 4 | COSC | Time constant for MPX limiting during adjacent channel carry over |
| 5 | DATA | Data input for DYNAS filter status. 7-bit serial data. TTL-CMOS input synchronic to CL |
| 6 | LOAD | Load input data, TTL-CMOS input |
| 7 | CL | Clock signal for data transmission (frequency see Electrical Characteristics table) |
| 8 | PL | Input of the comparator for adjacent channel carry over (plop-noise) |
| 9 | VCC 2 | Supply voltage for logic and audio circuits |
| 10 | GND 2 | Ground for logic and audio circuits |
| 11 | BUIN | Buffer input of filter tracking for bandpass filter |
| 12 | EQU | Input for high pass filtering and equalizing of MPX. Use of capacitors U 2 J (N 750) for temperature compensation are recommended, as indicated in the circuit diagram. |
| 13 | MPX | Output of MPX-signal |
| 14 | BMPX | Output buffer of the unequalized MPX-signal |
| 15 | TRVO | Tracking voltage for filter circuits |
| 16 | IAFC | Current source/sink output for tuning control. Connect to VREF if not used |
| 17 | HP 12 | Highpass filter in order to pre-emphasize the tracking voltage |
| 18 | HP 11 | Highpass filter in order to pre-emphasize the tracking voltage |
| 19 | AFIN 1 | Input of the AF processing network |
| 20 | AFIN 2 | Input of the AF processing network |
| 21 | AFOUT 2 | Differential amplifier output of the demodulator |
| 22 | AFOUT 1 | Differential amplifier output of the demodulator |
| 23 | BUC 2 | Buffer output for driving quadrature capacitor of the demodulator (Use of TC -220 ppm/°C for the capacitor 1.2 nF is recommended) |
| 24 | CDEM 2 | Resonant circuit for the demodulator (Use of TC -220 ppm/°C for the capacitor 120 pF is recommended) |
| 25 | CDEM 1 | Resonant circuit for the demodulator (Use of TC –220 ppm/°C for the capacitor 120 pF is recommended) |
| 26 | BUC 1 | Buffer output for driving quadrature capacitor of the demodulator (Use of TC – 220 ppm/°C for the capacitor 1.2 nF is recommended) |
| 27 | VCC 3 | Supply voltage for demodulator and filter circuit |
| 28 | GND 3 | Ground of demodulator and filter circuit |
| 29 | FIT | Test output for adjustment of the filter circuits |
| 30 | CDC 2 | Low passfilter for the offset cancellation of the limiting amplifier |
| 31 | FIL 4 | Resonant circuit 4, L4 166 uH TOKO 0555, Varicap TOKO KV 1234Z or equivalent |
| 32 | CDC 1 | Low passfilter for the offset cancellation of the limiting amplifier |
| 33 | FIL 3 | Resonant circuit 3, L3 157 uH TOKO 0555, Varicap TOKO KV 1234Z or equivalent |
| 34 | VCEN | Center voltage 2.5 V for filter circuits |
| 35 | FIL 2 | Resonant circuit 2, L2 112 uH TOKO 0554, Varicap TOKO KV 1234Z or equivalent |
| 36 | BUOUT | Buffer output of filter tracking voltage for bandpass filter |
| 37 | FIL 1 | Resonant circuit 1, L1 143 uH TOKO 0555, Varicap TOKO KV 1234Z or equivalent |
| 38 | VCC 1 | Supply voltage for mixer, oscillator, IF detector |
| 39 | GND 1 | Ground for mixer, oscillator, IF detector |
| 40 | VIN 1 | IF input 10.7 MHz |
| 41 | VIN 2 | Center voltage for the input 10.7 MHz |
| 42 | RSSI | Signal fieldstrength 0 to 100 µA to ground |
| 43 | Q 2 | X'tal 10 MHz |
| 44 | Q 1 | X'tal 10 MHz |

System Description

DYNAS is a completely new system of intermediatefrequency signal processing in order to reduce interference in FM radio reception. The principle function of the system is shown in figure 2, 3 and 4. It describes the relationship between the receiving signal condition and the system's reaction.





In case of a reasonable desired signal level and no or weak

interference signal level, as shown in figure 3, the system

has to be switched to the wide I.F. bandwidth. Therefore,

the usual high-fidelity stereo performance is achieved.

Figure 2.

Figure 2 shows a very high adjacent channel interference. In this case, the system has to be switched to the narrow bandwidth and the resonant frequency of the IF-filter will track the desired signal frequency. Because of the narrow bandwidth, the undesired signal cannot interfere with the desired channel. In this way, DYNAS avoids channel interference, the stereo reception will change to mono, which minimizes the interference noise.

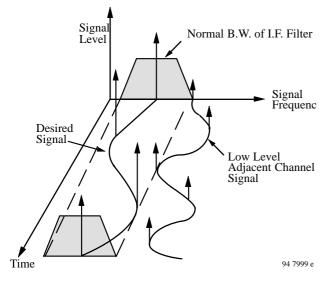


Figure 4 shows DYNAS's reaction to very low desired signal level. In this case, the system has to be switched to "mixed" narrow I.F. bandwidth in order to reduce the noise level feeding the FM discriminator. This increases the sensitivity of the receiver as seen from the S/N curve in figure 4. Certainly, because of the low signal and narrow bandwidth, only mono reception is possible.

Figure 4.

The DYNAS system using the U4292B provides 8 different I.F. bandpass characteristics, which are controlled by software according to the receiving conditions. Some of these characteristics have a "mixed" structure of narrow bandpass and wide bandpass characteristics.



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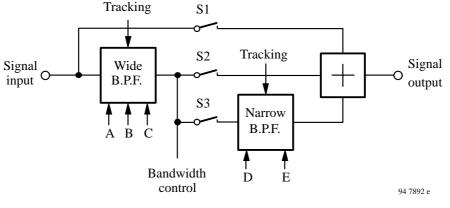


Figure 5.

| Receiving Conditions | | Characteristic | System Bandwidth | Sw | itch Positi | on |
|----------------------|-------------------------|----------------|------------------|------------|-------------|------------|
| Desired Signal | Adjacent Channel Signal | | | S 1 | S2 | S 3 |
| Strong | No | BYP | Bypassed | On | Off | Off |
| <u>+</u> +++ | † | ACH0 | 100 kHz | Off | On | Off |
| <u>†</u> †† | † † | ACH1 | 70 kHz | Off | On | Off |
| <u>†</u> † | <u>†</u> †† | ACH2 | Mixed | Off | On | On |
| 1 | <u>+</u> +++ | ACH3 | 23 kHz | Off | Off | On |
| † | Strong | ACH4 | 18 kHz | Off | Off | On |
| 1 | Weak | F1 | Mixed | Off | On | On |
| Weak | Weak | F2 | Mixed | Off | On | On |

Figure 6.

Figure 5 shows the structure of the DYNAS filter block, which mainly consists of 2 tracking bandpass filters: the "wide" bandpass filter and the "narrow" bandpass filter. The bandwidth of these bandpass filters can be changed by damping of the filter tanks. The signal path can be switched by the "symbolic" switches S1 to S3.

The table of figure 6 shows all possible bandpass characteristics of the system which can be achieved by combining of filter damping and signal path switching depending on the condition of the receiving signals (desired signal and adjacent channel signal).

If the desired signal is strong and there is no or very low adjacent channel interference, the system has to be switched in the "Bypass-Mode", which allows a maximum of bandwidth. In some special situation of multipath reception or common channel interference, the system's filter structure should be switched to the wide band characteristic BYP.

The characteristics ACH2, F1 and F2 (mixed mode) are obtained by adding the signals of the wide band and the narrow band signal paths (S2 and S3 are switched on). In this case a wide bandpass filter characteristic with a added "peak" of a narrow bandpass filter characteristic is achieved. Certainly characteristics like these cannot be characterized by a normal 3 dB bandwidth value in the table. Such "step bandwidth" characteristics are useful for given signal conditions where the advantage of the narrow band pass characteristic is required but on the other side its disadvantages should be minimized by superimposing the signal from the wide band signal path as mentioned above.

Functional Description

Figure 1 shows the block diagram of the U4292B. In the BYP mode (bypass function) the signal of mixer 2 is fed to the summing amplifier A 10, bypassing the DYNAS filters FIL 1, FIL 2, FIL 3 and FIL 4. In the other modes, the incoming signal is fed via a gain controlled amplifier A1 to the mixer 1. The filter characteristics are set according to the condition of the incoming signal by switches S 3 to S 8 which are controlled by software.

The 700 kHz DYNAS IF signal is available at output FIT for test and alignment purposes. In addition it is fed via the limiting amplifier LA to the FM DETECTOR which is a normal Quad-Demodulator. The demodulated signal is fed out at AFOUT 1 and AFOUT 2 to an external bandpass filter and reenters at AFIN 1 and AFIN 2, where it is fed to the buffer amplifier A 15 and the linearization circuit.

The MPX signal is available at output MPX. The tracking signal for the DYNAS filters is derived from the linearization circuit and it is available at output TRVO.

Depending on the condition of the tuned signal, the filter characteristics of the DYNAS IC U4292B are controlled by software according to figure 7.

| Condition | | Data | | | | | | |
|-----------|-----|------|---|---|---|---|---|-----|
| | MSB | | | | | | | LSB |
| | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| BYP | 0 | 0 | 0 | 0 | 0 | 0 | 0 | Х |
| ACH 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | Х |
| ACH 1 | 1 | 0 | 1 | 0 | 0 | 0 | 0 | Х |
| ACH 2 | 1 | 0 | 1 | 1 | 0 | 0 | 0 | Х |
| ACH 3 | 1 | 0 | 1 | 1 | 1 | 0 | 0 | Х |
| ACH 4 | 1 | 0 | 1 | 1 | 1 | 1 | 0 | Х |
| F 1 | 1 | 1 | 0 | 0 | 0 | 0 | 0 | Х |
| F 2 | 1 | 1 | 0 | 0 | 0 | 0 | 1 | Х |

Figure 7.

The U4292B has a 8-bit-shift register which is controlled by software via a 3 wire bus consisting of Clock, Data and Load. The timing diagrams of the bus are shown in figure 8.

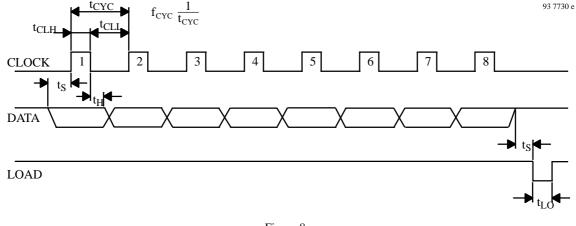
The system can be forced directly to the bypass function by switching Load, Clock and Data to "low" and it remains as long as Load and Data are "low" (see figure 9).

After releasing these conditions, the system will go back

to the previous status of the shift register.

Only in the ACH 4-status, a "Plop"-recognition is possible. During this time, the Load is internally disabled and a data-transfer cannot be executed. The signal at BMPX is fed via a low pass filter to the "Plop"-comparator. The internal switching threshold is determined at 400 mV_{PP} \pm 20% and the MPX signal is limited to 500 mV_{pp} (see figure 10).

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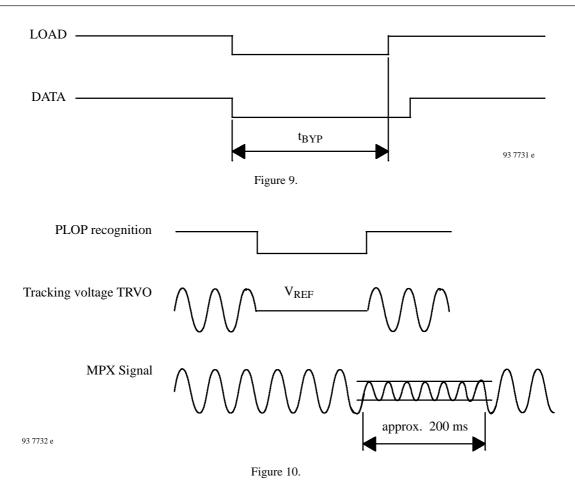




U4292B

ΤΕΜΙΟ

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Absolute Maximum Ratings

| Parameters | Symbol | Value | Unit |
|---------------------------|------------------|--------------|------|
| Supply voltage | V _{CC} | 13 | V |
| Power dissipation | P _{tot} | 750 | mW |
| Storage temperature range | T _{stg} | -50 to +125 | °C |
| Ambient temperature range | T _{amb} | -30 to +85 | °C |
| Junction temperature | Ti | 125 | °C |
| Electrostatic handling | $\pm V_{ESD}$ | 2000 | V |

Thermal Resistance

| Parameters | Symbol | Value | Unit |
|--------------------|-------------------|-------|------|
| Thermal resistance | R _{thJA} | 120 | K/W |

Electrical Characteristics

 $V_S = 8.2$ V, $T_{amb} = 25^{\circ}$ C, $V_{IN1} = 30$ mV, 10.7 MHz, FM = ± 75 kHz deviation, fmod = 1 kHz, unless otherwise specified. Ve is the input voltage of the front end imitation (FEI) with 40 dB voltage gain and 6 dB noise figure.

The voltage V_e is defined under a termination of 50 Ω . V_{IN1} is the applied input voltage at pin VIN1 of the U4292B, reference point is ground, de-emphasis is 75 μ s, normally out. AF bandwidth for audio measurement is 30 kHz.

| Parameters | Test Conditions / Pins | Symbol | Min. | Тур. | Max. | Unit |
|--------------------------|---|--------------------------------------|------|--------------|------|-------|
| Supply voltage | Pins 38, 27 and 9 | V _{CC1} | 7.5 | 8.2 | 9 | V |
| | | V _{CC2} V _{CC3} | | | | |
| Supply quiescent current | Pins 38, 27 and 9 | • (13 | | | | |
| suppry quiescent current | $I_{CC} = I_{CC1} + I_{CC2} + I_{CC3}$ | I _{CC} | | 63 | 75 | mA |
| Reference voltage output | Pin 3 | | | | ,,, | |
| Reference voltage | | V _{REF} | 4.7 | 5 | 5.3 | V |
| Output resistance | | R _{OUT} | | 2.5 | | Ω |
| Load current | | IL | | | 10 | mA |
| TC | | -L | | 0.1 | | mV/°C |
| Center voltage output | Pin 34 | | | | 1 | |
| Center voltage | | V _{CEN} | 2.3 | 2.5 | 2.7 | V |
| Output resistance | | R _{OUT} | | 1 | | Ω |
| Load current | | IL | | | 1 | mA |
| TC | | | | -1.4 | | mV/°C |
| Demodulator outputs | Pins 22 and 21 | | | | | |
| Output resistance | | R _{OUT} | | 2.4 | | kΩ |
| Tracking voltage output | Pin 15 | 001 | | | 1 | |
| Bias voltage | | V _{BIAS} | | 5 | | V |
| IF input | Pin 40 | Dirio | | | | |
| Input voltage (rms) | | V _{IN1} | | | 200 | mV |
| Input resistance | | R _{IN} | | 1.2 | | kΩ |
| AGC-threshold input | Mode F1 | V _{AGC} | | 130 | | μV |
| voltage | | | | | | |
| MPX output | Pin 13 | | | | | |
| Recovered audio output | 22.5 kHz deviation | V _{OUT} | | 180 | | mV |
| voltage (rms) | 75 kHz deviation | | | 600 | | |
| THD without de-emphasis | Mode BYP | | | | | |
| | $Ve = 60 \text{ dB}\mu V$ | | | 0.21 | | |
| | 1 kHz, 22.5 kHz deviation 8 kHz, 22.5 kHz deviation | | | 0.31 0.70 | | % |
| | 1 kHz, 75 kHz deviation | | | 0.70 | | 70 |
| THD without de-emphasis | Mode ACH0 | | | 0.05 | | |
| THE without de emphasis | $V_e = 30 \text{ dB}\mu\text{V}$ | | | | | |
| | 1 kHz, 22.5 kHz deviation | | | 0.65 | | |
| | 8 kHz, 22.5 kHz deviation | | | 0.90 | | % |
| | 1 kHz, 75 kHz deviation | | | 1.00 | | |
| THD with de-emphasis | Mode ACH0 | | | | | |
| | $V_e = 30 \text{ dB}\mu\text{V}$ | | | 0.12 | | 0/ |
| | 1 kHz, 22.5 kHz deviation | | | 0.13 | | % |
| THD with de-emphasis | Mode F1 $V_e = 10 dB\mu V$ | | | | | |
| | $v_e = 10 \text{ dB}\mu v$ 1 kHz, 22.5 kHz deviation | | | 0.8 | | % |

Electrical Characteristics

| Parameters | Test Conditions / Pins | Symbol | Min. | Тур. | Max. | Unit |
|---|--------------------------------------|------------------------------------|------|------|------|-----------------|
| (S+N)/N ratio | Mode BYP | | | | | |
| with de-emphasis | $V_e = 60 \text{ dB}\mu V$ | | | | | |
| | 22.5 kHz deviation | | | 75 | | dB |
| | 75 kHz deviation | | | 85 | | |
| (S+N)/N ratio | Mode ACH0 | | | | | |
| with de-emphasis | $V_e = 30 \text{ dB}\mu V$ | | | | | |
| | 22.5 kHz deviation | | | 61 | | dB |
| | 75 kHz deviation | | | 72 | | |
| (S+N)/N ratio | Mode F1 | | | | | |
| with de-emphasis | $V_e = 60 \text{ dB}\mu V$ | | | | | |
| | 22.5 kHz deviation | | | 42 | | dB |
| | 75 kHz deviation | | | 53 | | |
| AM suppression | $V_{IN1} = 5 mV$, | | | -38 | | dB |
| | 90 % modulation | | | | | |
| | 22.5 kHz deviation | | | | | |
| Adjacent channel | SINAD = 30 dB, | | | | | |
| selectivity | Desired signal: | | | | | |
| - | $f_{IF} = 10.7 \text{ MHz},$ | | | | | |
| | $V_e = 10 \text{ dB}\mu V$, | | | | | |
| | $f_{mod} = 1 \text{ kHz},$ | | | | | |
| | deviation $= 35$ kHz, | | | | | |
| | Adjacent signal: | | | | | |
| | $f_{mod} = 400 \text{ kHz},$ | | | | | |
| | deviation = 35 kHz | | | | | |
| | f = 10.5 MHz | | | 84 | | |
| | f = 10.6 MHz | | | 44 | | dBµV |
| | f = 10.8 MHz | | | 40 | | |
| | f = 10.9 MHz | | | 83 | | |
| Usable sensitivity | 40 kHz deviation and | | | | | |
| | input voltage V _e –3 dBµV | | | 30 | | dB |
| Tracking range | $Ve = 10 dB\mu V$ and | | | | | |
| | SINAD = 26 dB | | | | | |
| | fmod = 1 kHz | | | >75 | | kHz |
| | fmod = 8 kHz | | | 50 | | |
| | (de-emphasis on) | | | | | |
| Voltage gain | Mode BYP, ACH0, | | | 12.5 | | dB |
| V _{MPX} | ACH1 or ACH2 | | | | | |
| V _{BMPX} | f = 1 kHz, without mute | | | | | |
| AFC output | Pin 16 | | | | | |
| Output current sensitivity | I _{AFC} vs. frequency | I _{AFC} | | 0.2 | | µA/kHz |
| - 2 | deviation | $\frac{\Lambda re}{\Delta f_{IF}}$ | | | | . |
| Oscillator | Pins 43 and 44 | | | | | 1 |
| Oscillator 10 MHz voltage swing | | V _{OSC} | | 0.8 | | V _{PP} |
| BMPX output | Pin 14 | 1 | | I | 1 | I |
| V | f = 1 kHZ | | | 0 | | dB |
| Voltage gain $\frac{V_{BMPX}}{\Delta V_{AFIN}}$ | | | | | | |
| - · AFIN | | | | | | |

Electrical Characteristics

| Parameters | Test Conditions / Pins | Symbol | Min. | Тур. | Max. | Unit |
|--|--|--|-------------|--------------|--------------|------------------|
| Tracking voltage output | Pin 15 | | | | | |
| Voltage gain $\frac{V_{TRVO}}{\Delta V_{AFIN}}$ | Mode ACH3, ACH4 other modes, f = 1 kHz | | | 12.6 10.2 | | dB |
| Buffer output | Pin 36 | | | | | • |
| Voltage gain $\frac{V_{BUOUT}}{V_{BUIN}}$ | f = 1 kHz | | | 0 | | dB |
| Field strength output RSSI | Pin 42 | | | | | |
| Output voltage | $\label{eq:loss} \left \begin{array}{l} R_{LOAD} = 10 \ k\Omega \\ V_{IN1} = 100 \ \mu V \\ V_{IN1} = 100 \ mV \end{array} \right.$ | Vo | 0.2 0.85 | | 0.45 1.35 | V |
| Deviation of RSSI from linearity (RSSI vs. input voltage level in dB), with respect to the ideal value on a straight line connect- ing the start and end values defined before | | | -6 -6 | | 6 6 | % |
| Test output | Pin 29 | | | | | |
| Voltage swing | $V_{IN1} = 5 \text{ mV},$ without modulation | | | 85 | | mV _{PP} |
| Input Data, Load, Clock | Pins 5, 6 and 7 | | | - | | - |
| Input voltage High Low | | V _{IH} V _{IL} | 2.5 0 | | 5 0.8 | V |
| Input current High Low | | I _{SOURCE} I _{SINK} | | +1 -1 | +5 -5 | μΑ |
| Transfer clock cycle time | | f _{CYC} | | | 300*1 | kHz |
| Transfer clock high level width | | tCLH | 1 | | | μs |
| Transfer clock low level width | | t _{CLL} | 1 | | | μs |
| Transfer Load low level width | | t _{LO} | 1 | | | μs |
| Data set up time | | t _S | 1 | | | μs |
| Data hold time | | t _H | 100 | | | ns |

*1 Frequencies between 200 and 266 kHz are not allowed.

Application Circuit

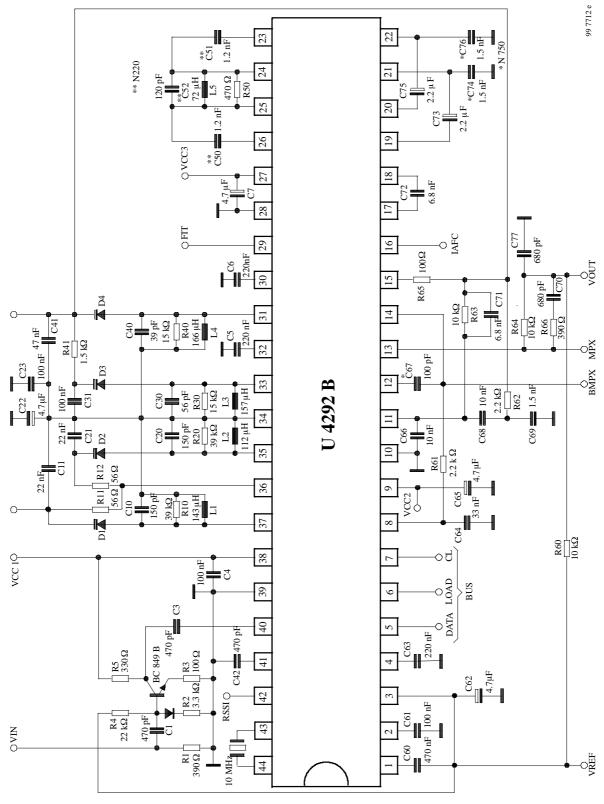


Figure 11.

Preliminary Information

Filter Adjustment Procedure

Connect the generator to input VIN and an oscilloscope to output FIT. Connect a dc current meter (this may be a DVM in connection with a 100 k Ω resistor) between pins IAFC and VREF.

- 1. Set the IF center frequency of the FM-front end to 10.7 MHz (\pm filter offset) with a signal level of approx. 1 mV and adjust L 3 and L 4 to the maximum voltage at output FIT.
- 2. Reduce the generator output voltage until the AGC switches off and V_{FIT} decreases.
- 3. Tune L 2 and L 1 to resonance whilst maintain a low signal at FIT to prevent AGC action.
- 4. Note a value V of V_{FIT} at a given generator output voltage.
- 5. Increase the generator output voltage by about 7 dB and adjust L 1 to a lower frequency until the value V_a is reached again.
- 6. Increase the generator output voltage by about 7 dB and adjust L 2 to a higher frequency until the value V_a is reached once again.
- 7. Tune L 5 until $I_{IAFC} = 0$

An alternative procedure is:

- 4b. Set the generator to 10.7 MHz 16 kHz(± filter offset)
- 5b. Tune L 1 to resonance
- 6b. Set the generator to 10.7 MHz + 16 kHz(± filter offset)
- 7b. Tune L 2 to resonance

This procedure appears more accurate then the first.

Temperature compensation of the demodulator circuit:

Low TC of the demodulator centre frequency requires about TC-220 ppm of the capacitors C 50, C 51, C 52.

Specification of external elements

Crystal 10 MHz

Frequency tolerance at 25 °C: \pm 100 ppm TC of frequency: < 5 ppm/°C Equivalent series resistance: < 80 Ω

Varactors D1 to D4: TOKO KV 1234Z is recommended

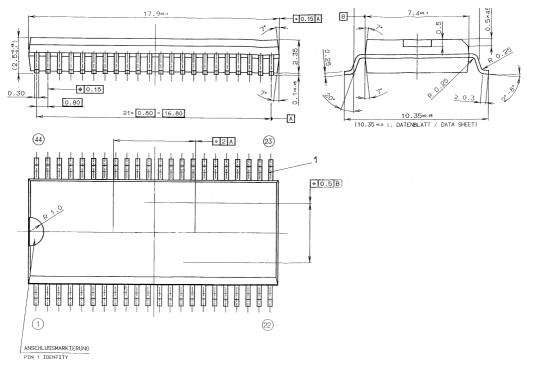
Coils: L2, L5: Q > 110, TOKO 0554 is recommended L3, L4, L1: Q > 120, TOKO 0555 is recommended

Ordering and Package Information

| Extended Type Number | Package | Remarks |
|----------------------|---------|---------|
| U4292B-AFS | SSO44 | |

Dimensions in mm

Package: SSO44



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- 2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

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- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

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